

**Search Notes**

Application/Control No.

10/552,860

Examiner

HIEU T. VO

Applicant(s)/Patent under  
Reexamination

PITZAL ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
123	493 320 339.19 339.22 339.21	4/16/2007	VH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
All of above		4/16/2007	VH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/16/2007	VH